

LRIS facility (SAIF/CSIF, IIT-B) - Request Form

Every field in Request Form is mandatory. Edit the PDF itself, highlight correct options.

User's Name				
User's Phone Number				
User's Email ID				
Institute				
Guide				
Guide's Phone Number				
Guide's Email ID				
No. of Samples	5			
Type of Analysis	Spectral Analysis - Uniform Solid / Liquids			
	Spectral Analysis - Composites / Microstructures			
	Spectral Analysis - Multiple Data Points / Low Wavenumber			
	In-Situ Measurements			
	UV-PL			
	Mapping			
	Temperature-dependent Analysis			
	Polarization-dependent Analysis			
Signal	Raman		PL	
Excitation Laser Wavelength	325 nm	532 nm	633 nm	830 nm
Sample Description	Graphene based Composite			
Hazardous	Yes		No	
Highly Volatile	Yes		No	
Flash Point less than 60°C	Yes		No	
Raman / PL peaks expected at -	1365 , 1580, 2765 cm-1			
Remarks				